

Notice of References Cited	Application/Control No. 10/728,406	Applicant(s)/Patent Under Reexamination NOWAK ET AL.	
	Examiner Tai Van Nguyen	Art Unit 3729	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,249,407	06-2001	Aoshima et al.	360/324.2
*	B	US-5,668,688	09-1997	Dykes et al.	360/324.1
*	C	US-6,560,077	05-2003	Fujiwara et al.	360/324.1
*	D	US-6,198,609	03-2001	Barr et al.	360/322
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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